

Uncertainty (%)	$d\sigma/dp_T^{\text{leading}}$	$d\sigma/dp_T^{\text{subleading}}$	$d\sigma/dp_T^Z$	$d\sigma/dM_{bb}$	$d\sigma/dM_{Zbb}$
JER	0.3–8.3	0.7–7.9	0.1–3.8	0.9–4.1	2.9–12.0
JES	4.4–17.0	7.7–23.3	3.1–20.3	6.7–15.3	3.8–16.2
Unfolding (MC model)	0.0–74.4	0.0–52.6	0.0–53.6	0.0–37.8	0.0–57.3
Unfolding (MC statistics)	8.0–39.4	9.0–35.8	8.8–27.0	7.6–28.0	10.0–20.8
c, udsg background model	0.0–17.3	0.0–16.1	0.0–15.5	0.0–18.5	0.0–10.2
Electron (muon) efficiency	1.5 (2.0)	1.5 (2.0)	1.5 (2.0)	1.5 (2.0)	1.5 (2.0)
b tagging efficiency	6.0	6.0	6.0	6.0	6.0
Pileup	0.4–14.1	0.3–11.4	1.3–9.6	1.1–5.7	0.2–4.3
Background (systematic)	0.3–0.9	0.1–0.7	0.3–1.2	0.0–1.4	0.3–1.3
Background (statistical)	3.1–17.4	4.0–24.2	4.2–15.0	4.3–15.0	5.8–10.2
Integrated luminosity	2.6	2.6	2.6	2.6	2.6
Total syst. uncertainty (%)	17.2–89.4	19.7–61.7	17.8–56.6	14.5–52.9	17.9–65.4
Total stat. uncertainty (%)	6.1–34.1	7.6–44.5	10.4–23.5	7.9–28.0	11.2–19.9